


<b>Search Notes</b>  	<b>Application/Control No.</b>  10557292	<b>Applicant(s)/Patent Under Reexamination</b>  KAYAMA ET AL.
	<b>Examiner</b>  ANEETA PATANKAR	<b>Art Unit</b>  4134

SEARCHED			
Class	Subclass	Date	Examiner
369	44.11, 53.26, 120	4/8/2008	AVP

SEARCH NOTES		
Search Notes	Date	Examiner
East	4/8/2008	AVP
Inventor Search	4/8/2008	AVP
Consulted with Joseph Haley	4/8/2008	AVP
EAST	12/5/08	A.P.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/A. P./ Examiner.Art Unit 2627	
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